

| | | | | |
|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/518,696 | | Applicant(s)/Patent Under Reexamination MEKATA, SATOSHI | |
| | Examiner Andrew P. Bainbridge | | Art Unit 4156 | Page 1 of 3 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------------|----------------|
| * | A | US-2,973,883 A | 03-1961 | PAUL MODDERNO JOHN | 222/94 |
| * | B | US-3,217,936 A | 11-1965 | HENRY ABPLANALP ROBERT | 222/136 |
| * | C | US-3,295,727 A | 01-1967 | IRVING KATES; et. al. | 222/136 |
| * | D | US-3,325,056 A | 06-1967 | LEWIS WILLIAM D | 222/94 |
| * | E | US-3,482,736 A | 12-1969 | GREEN DEREK BERNARD | 222/94 |
| * | F | US-3,511,414 A | 05-1970 | KINNAVY JAMES W; et. al. | 222/136 |
| * | G | US-3,540,623 A | 11-1970 | WITTKE JOHN M; et. al. | 222/94 |
| * | H | US-3,608,782 A | 09-1971 | Sathicq, Robert | 222/94 |
| * | I | US-3,685,696 A | 08-1972 | Marraffino, Leonard L. | 222/136 |
| * | J | US-3,704,814 A | 12-1972 | Ruscitti, Tomaso | 222/136 |
| * | K | US-3,720,376 A | 03-1973 | Morane et al. | 239/308 |
| * | L | US-3,722,750 A | 03-1973 | Fox, Jr., Charles F. | 222/94 |
| * | M | US-4,355,739 A | 10-1982 | Vierkotter, Peter | 222/134 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | | |
|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/518,696 | | Applicant(s)/Patent Under Reexamination MEKATA, SATOSHI | |
| | Examiner Andrew P. Bainbridge | | Art Unit 4156 | Page 2 of 3 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------|----------------|
| * | A | US-4,469,252 A | 09-1984 | Obrist, Gerhard | 222/135 |
| * | B | US-5,034,014 A | 07-1991 | Wenke, Gottfried | 8/408 |
| * | C | US-5,071,038 A | 12-1991 | Credle, Jr., William S. | 222/129.2 |
| * | D | US-5,153,231 A | 10-1992 | Bouquet et al. | 521/88 |
| * | E | US-5,167,347 A | 12-1992 | Wiegner et al. | 222/94 |
| * | F | US-5,215,225 A | 06-1993 | Kopp, Volker | 222/129 |
| * | G | US-5,348,392 A | 09-1994 | Bouquet et al. | 366/162.3 |
| * | H | US-5,387,034 A | 02-1995 | Bauer et al. | 366/130 |
| * | I | US-5,433,350 A | 07-1995 | Graubart, Beth T. G. | 222/136 |
| * | J | US-5,439,141 A | 08-1995 | Clark et al. | 222/136 |
| * | K | US-5,820,956 A | 10-1998 | Hatakeyama et al. | 428/36.6 |
| * | L | US-6,182,865 B1 | 02-2001 | Bunschoten et al. | 222/136 |
| * | M | US-2001/0027981 A1 | 10-2001 | Yquel, Jean-Pierre | 222/136 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | | |
|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/518,696 | | Applicant(s)/Patent Under Reexamination MEKATA, SATOSHI | |
| | Examiner Andrew P. Bainbridge | | Art Unit 4156 | Page 3 of 3 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-6,520,377 B2 | 02-2003 | Yquel, Jean-Pierre | 222/1 |
| * | B | US-2004/0226964 A1 | 11-2004 | Bourque et al. | 222/136 |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.